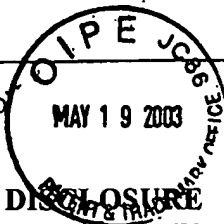


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(Revised 10/2001)

**INFORMATION DISCLOSURE
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Sheet 1 of 1



Complete if Known

Application Number 10/089,010
Filing Date 03/25/2002
First Named Inventor Ahn
Group Art Unit 2681

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Examiner Name Unknown
Attorney Docket Number 38779/245435

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U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number Number - Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages of Relevant Figures Appear
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<u>WK</u>	<u>4</u>	<u>KR-10-2000-0031583</u>	<u>06/05/2000</u>	<u>Park, et al.</u>		*English Abstract Attached

Examiner
Signature

Mesley Kim

Date
Considered

6/25/05

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(Revised 10/2001)

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Sheet 1 of 1

Complete if Known

Application Number 10/089,010
Filing Date March 25, 2002
First Named Inventor Byung-Ik AHN, et al.
Group Art Unit
Examiner Name

Attorney Docket Number 38779/245435

U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number Number - Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages of Relevant Figures Appear
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		US-			
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WK	1	EP 0 786 915 A2 /	07-30-1997	Kokusai Denshin Denwa Co., Ltd.		
WK	2	GB 2 345 825 A /	07-19-2000	Samsung Electronics Co. Limited		
WK	3	EP 1 059 822 A2 /	12-13-2000	Nokia Mobile Phones Ltd.		

Examiner Signature	Wolke Kim	Date Considered	6/20/05
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